

**Search Notes**

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Examiner

Patricia Leith

Applicant(s)/Patent under  
Reexamination

SAKANAKA ET AL.

Art Unit

1655

**SEARCHED**

Class	Subclass	Date	Examiner
424	728,725	10/27/2006	PL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
424	725,728	10/27/2006	PL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST: JPO,EPO,DERWENT,USPATFULL,U SPGPUBS,OCRBKFILE updated	10/27/2006	PL
Inventor name search updated EAST/PALM	10/27/2006	PL